

## Dual N-Channel 20-V (D-S) MOSFET

### Description

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low rDS(on) and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

### Features

- Low rDS(on) provides higher efficiency and extends battery life
- Low thermal impedance copper lead frame TSSOP-8 saves board space
- Fast switching speed
- High performance trench technology

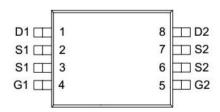
#### Typical Applications:

- · Battery Powered Instruments
- · Portable Computing
- · Mobile Phones
- · GPS Units and Media Players
- · RoHS compliant package

Package type: TSSOP-8

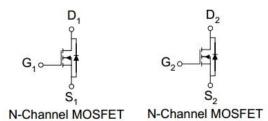
Packing & Order Information

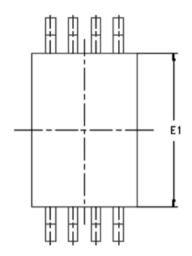
3,000/Reel

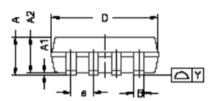


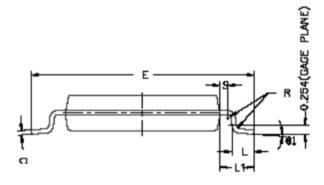
RoHS COMPLIANT

### Graphic symbol









5	MILLIMETERS				
DIM.	MIN.	NDM.	MAX.		
A	1.05	1.10	1.20		
A(1)	0.05	0.10	0.15		
A(2)	g.99	1.02	1.05		
В	D.19	0.25	0.30		
C		0.127			
D	2.90	3.0D	3.10		
Ε	6.20	6.40	6.60		
E1	4.30 4.40 4.		4.50		
В	0.65950				
L	0.45 0.60 0.7				
L1	0.90	1.00	1.10		
Y			0.10		
<b>0</b> 1	D.	4	E*		
R	D.Q9				
S	0.20				



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## MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (T <sub>A</sub> =25°C unless otherwise specified)					
Symbol	Parameter	Value	Unit		
$V_{DS}$	Drain-Source Voltage	20	V		
$V_{GS}$	Gate-Source Voltage	±8	V		
т	Continuous Drain Current <sup>a</sup> (T <sub>A</sub> =25°C)	6.8	A		
$ m I_D$	Continuous Drain Current <sup>a</sup> (T <sub>A</sub> =70°C)	5.5	A		
$I_{DM}$	Pulsed Drain Current <sup>b</sup>	30	A		
Is	Continuous Source Current (Diode Conduction) <sup>a</sup>	2.2	A		
D	Power Dissipation <sup>a</sup> (T <sub>A</sub> =25°C)	1.5	W		
$P_D$	Power Dissipation <sup>a</sup> (T <sub>A</sub> =70°C)	1	W		
T <sub>J</sub> /T <sub>STG</sub>	Operating Junction and Storage Temperature	-55 to +150	°C		

Thermal Resistance Ratings						
Symbol	Parameter Maximum Units					
$R_{\theta JA}$	Maximum Junction-to-Ambient <sup>a</sup> (t <= 10 sec)	83	°C/W			
	Maximum Junction-to-Ambient <sup>a</sup> (Steady-State)	120	C/ <b>VV</b>			

### Notes

- a. Surface Mounted on 1" x 1" FR4 Board.
- b. Pulse width limited by maximum junction temperature

Static						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
$V_{GS(th)}$	Gate-Source Threshold Voltage	$V_{DS}=V_{GS},I_D\!=\text{-250}\mu\text{A}$	0.4			V
Igss	Gate-Body Leakage	$V_{DS} = 0 V$ , $V_{GS} = \pm 8 V$			±100	nA
Idss	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}$ , $V_{GS} = 0 \text{ V}$			1	uA
		$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55^{\circ}\text{C}$			10	
$I_{D(on)} \\$	On-State Drain Current	$V_{DS} = 5 \text{ V}, V_{Gs} = 4.5 \text{ V}$	25			A
r <sub>DS</sub> (on)	Drain-Source On-Resistance	$V_{DS} = 4.5 \text{ V}, I_D = 5.0 \text{ A}$			22	
		$V_{DS} = 2.5 \text{ V}, I_{D} = 4.3 \text{ A}$			30	mΩ
		$V_{DS} = 1.8 \text{ V}, I_D = 3.5 \text{ A}$			46	
g fs	Forward Tranconductance	$V_{GS} = 10 \text{ V}, I_D = 5.0 \text{ A}$		25		S
$V_{SD}$	Diode Forward Voltage	$I_S = 2.2 A$ , $V_{GS} = 0 V$		0.7		V



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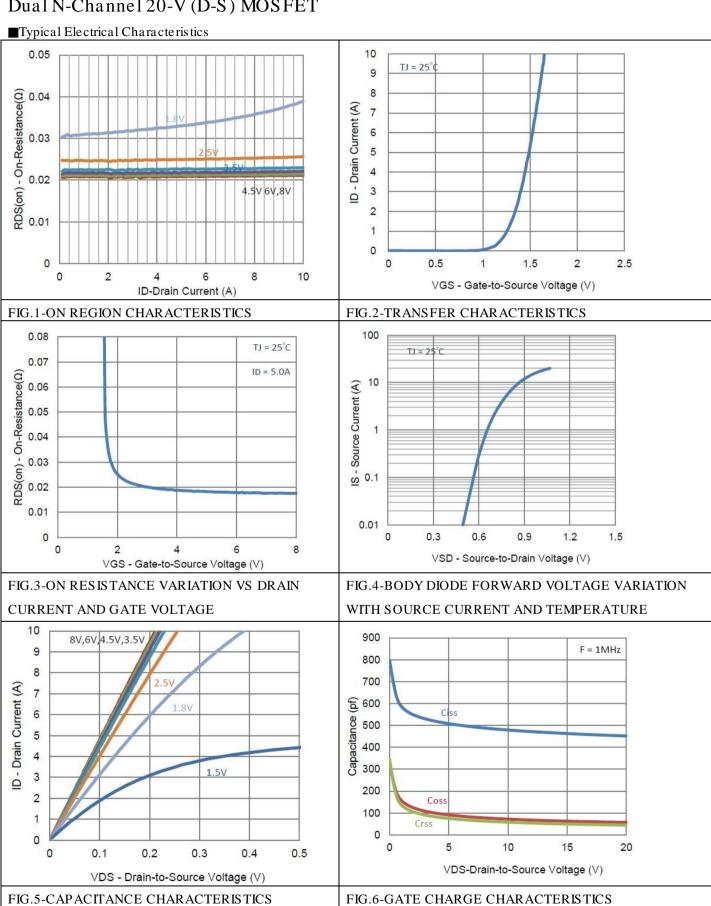
Dynamic						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
$Q_{\rm g}$	Total Gate Charge	$V_{DS} = 10 \text{ V}, I_{D} = 4.5 \text{ A},$ $V_{GS} = 5.0 \text{ V}$		6.2		nC
$Q_{gs}$	Gate-Source Charge			1.0		nC
$Q_{\mathrm{gd}}$	Gate-Drain Charge			1.9		nC
$t_{d(on)}$	Turn-On Delay Time	$I_{D} = 5.0 \text{ A}, R_{L} = 2.0 \Omega,$ $V_{GEN} = 10 \text{ V}, R_{GEN} = 6 \Omega$ $V_{DD} = 10 \text{ V}$		12		ns
$t_{\rm r}$	Rise Time			15		ns
$t_{d(\mathrm{off})} \\$	Turn-Off Delay Time			56		ns
tf	Fall Time			17		ns
Ciss	Input Capacitance	$V_{DS} = 10 \text{ V}$ $f = 1 \text{ MHz } , V_{GS} = 0 \text{ V}$		479		pF
Coss	Output Capacitance			72		pF
Crss	Reverse Transfer Capacitance			58		pF

#### Notes

- a. Pulse test: PW <= 300us duty cycle <= 2%.
- b. Guaranteed by design, not subject to production testing.



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### ■Typical Electrical Characteristics

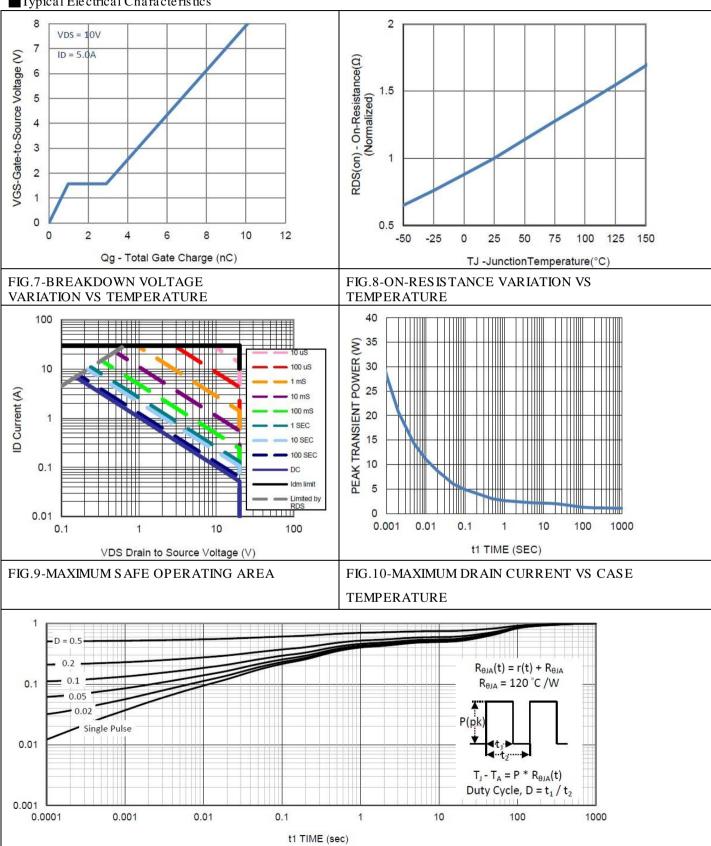


FIG.11-TRANSIENT THERMAL RESPONSE CURVE



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